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P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω) (Max.)	I _D (A)	Q _g (Typ.)		
- 20	0.0091 at V _{GS} = - 4.5 V	- 40 ^a	58 nC		
20	0.0115 at V _{GS} = - 2.5 V	- 30 ^a	36 NC		

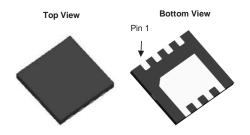
FEATURES

- DT-Trench Power MOSFET
- Thermally Enhanced DFN3X3 Package
 - Small Footprint Area
 - Low On-Resistance



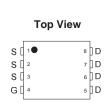
RoHS

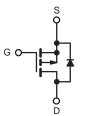
DFN 3x3 EP



APPLICATIONS

 Load Switch, PA Switch, and Battery Switch for Portable Devices





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$(T_A = 25 ^{\circ}C, unlet)$	ess otherwise n	noted)		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 20	V	
Gate-Source Voltage		V_{GS}	± 12		
	T _C = 25 °C		- 40 ^a		
Continuous Drain Current (T _J = 150 °C)	$T_C = 70 ^{\circ}C$ $T_A = 25 ^{\circ}C$	I _D	- 30 ^a - 25 ^{b, c}		
	T _A = 70 °C		- 18 ^{b, c}	Α	
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 160		
Continuous Source-Drain Diode Current	$T_C = 25 ^{\circ}\text{C}$ $T_A = 25 ^{\circ}\text{C}$	I _S	- 40 ^a - 28 ^{b, c}]	
M · · · · · · · · · · · · · · · · · · ·	$T_C = 25 ^{\circ}\text{C}$ $T_C = 70 ^{\circ}\text{C}$	D	60 25	10/	
Maximum Power Dissipation	$T_A = 25 ^{\circ}\text{C}$ $T_A = 70 ^{\circ}\text{C}$	P _D -	3 ^{b, c}	W	
Operating Junction and Storage Temperature Ran	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature) ^{d, e}		,	260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	30	40	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{th.IC}	2.3	3.5	C/ V V	

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. See solder profile The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80 °C/W.



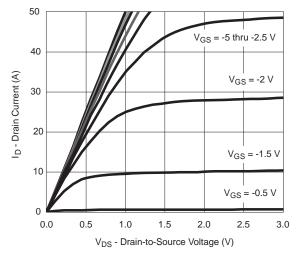
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 11		m\//°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = -250 \mu\text{A}$		2.7		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.5		- 1.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 12 V, V _{GS} = 0 V			- 1	μΑ	
		V _{DS} = - 12 V, V _{GS} = 0 V, T _J = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 40			Α	
Drain-Source On-State Resistance ^a		V _{GS} = - 4.5 V, I _D = - 5 A		0.0091	0.011	Ω	
	R _{DS(on)}	$V_{GS} = -2.5 \text{ V}, I_D = -5 \text{ A}$		0.0115	0.013		
Forward Transconductance ^a	g _{fs}	V _{DS} = - 12 V, I _D = - 10 A		50		S	
Dynamic ^b	<u>'</u>			'	'		
Input Capacitance	C _{iss}			10800		pF	
Output Capacitance	C _{oss}	V _{DS} = - 12 V, V _{GS} = 0 V, f = 1 MHz		3050			
Reverse Transfer Capacitance	C _{rss}			520			
Total Gate Charge	Q _g	V _{DS} = - 12 V, V _{GS} = - 8 V, I _D = - 10 A		58	97	nC	
				33	65		
Gate-Source Charge	Q _{gs}	$V_{DS} = -12V$, $V_{GS} = -4.5 V$, $I_{D} = -10 A$		7			
Gate-Drain Charge	Q _{gd}			15.5			
Gate Resistance	R _g	f = 1 MHz		5		Ω	
Turn-On Delay Time	t _{d(on)}			11			
Rise Time	t _r	$V_{DS} = -12 \text{ V}, R_{L} = 0.75 \Omega$		12		1	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -8 \text{ A}, V_{GS} = -4.5 \text{ V}, R_g = 1 \Omega$		72			
Fall Time	t _f			40		1	
Turn-On Delay Time	t _{d(on)}			21		ns	
Rise Time	t _r	$V_{DS} = -12V, R_{L} = 0.75 \Omega$		40		-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -8 \text{ A}, V_{GS} = -2.5 \text{ V}, R_g = 1 \Omega$		64			
Fall Time	t _f			40			
Drain-Source Body Diode Characterist	ics			•			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 40	٨	
Pulse Diode Forward Current	I _{SM}				160	A	
Body Diode Voltage	V _{SD}	I _S = -8 A, V _{GS} = 0 V		- 0.7	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			41		ns	
Body Diode Reverse Recovery Charge		I _F = -8 A, di/dt = 100 A/μs, T _J = 25 °C		22		nC	
Reverse Recovery Fall Time	t _a	$_{1F} = -6 \text{ A}, \text{ u/u} = 100 \text{ A/}\mu\text{s}, \text{I}_{J} = 25 ^{3}\text{C}$		14		ns	
Reverse Recovery Rise Time	t _b			26			

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

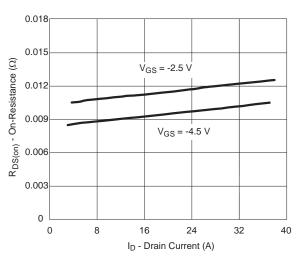
a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.



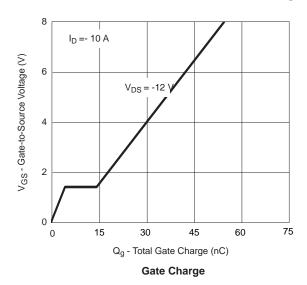
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

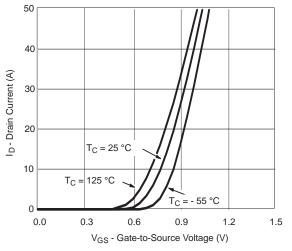


Output Characteristics

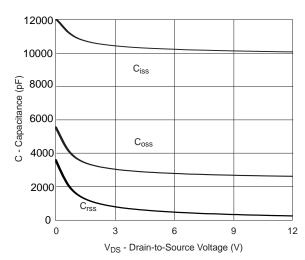


On-Resistance vs. Drain Current and Gate Voltage

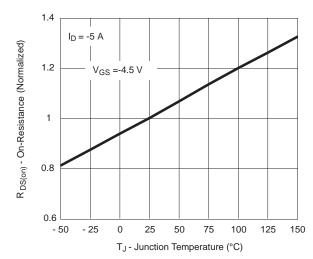




Transfer Characteristics



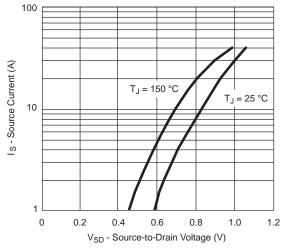
Capacitance



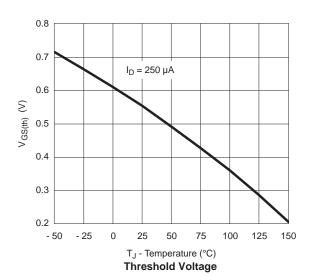
On-Resistance vs. Junction Temperature

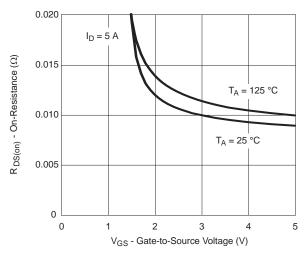


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

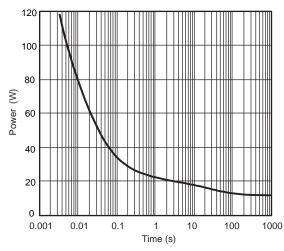


Soure-Drain Diode Forward Voltage

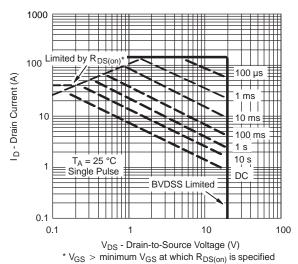




On-Resistance vs. Gate-to-Source Voltage



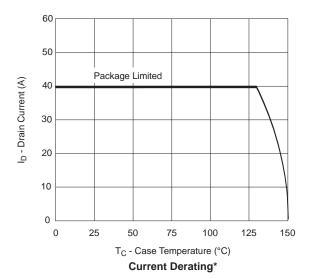
Single Pulse Power, Junction-to-Ambient

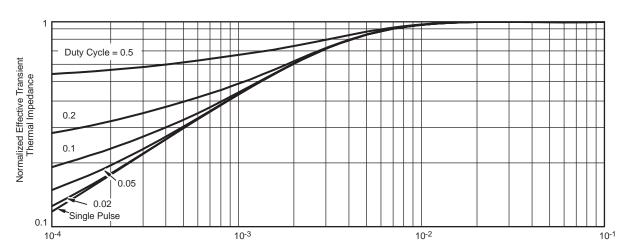


Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Normalized Thermal Transient Impedance, Junction-to-Case

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



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